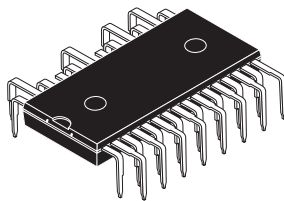
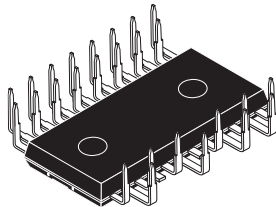


## SLLIMM-nano IPM, 3 A, 600 V, 3-phase inverter bridge IGBT



NDIP-26L

### Features

- IPM 3 A, 600 V, 3-phase IGBT inverter bridge including control ICs for gate driving and freewheeling diodes
- Optimized for low electromagnetic interferences
- $V_{CE(sat)}$  negative temperature coefficient
- 3.3 V, 5 V, 15 V CMOS/TTL input comparators with hysteresis and pull-down/pull-up resistors
- Undervoltage lockout
- Internal bootstrap diode
- Interlocking function
- Shutdown function
- Comparator for fault protection against overtemperature and overcurrent
- Op-amp for advanced current sensing
- Optimized pinout for easy board layout

### Applications

- 3-phase inverters for motor drives
- Dish washers
- Refrigerator compressors
- Air-conditioning fans
- Draining and recirculation pumps



### Description

This intelligent power module implements a compact, high performance AC motor drive in a simple, rugged design. It is composed of six IGBTs with freewheeling diodes and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM™ is a trademark of STMicroelectronics.

#### Product status

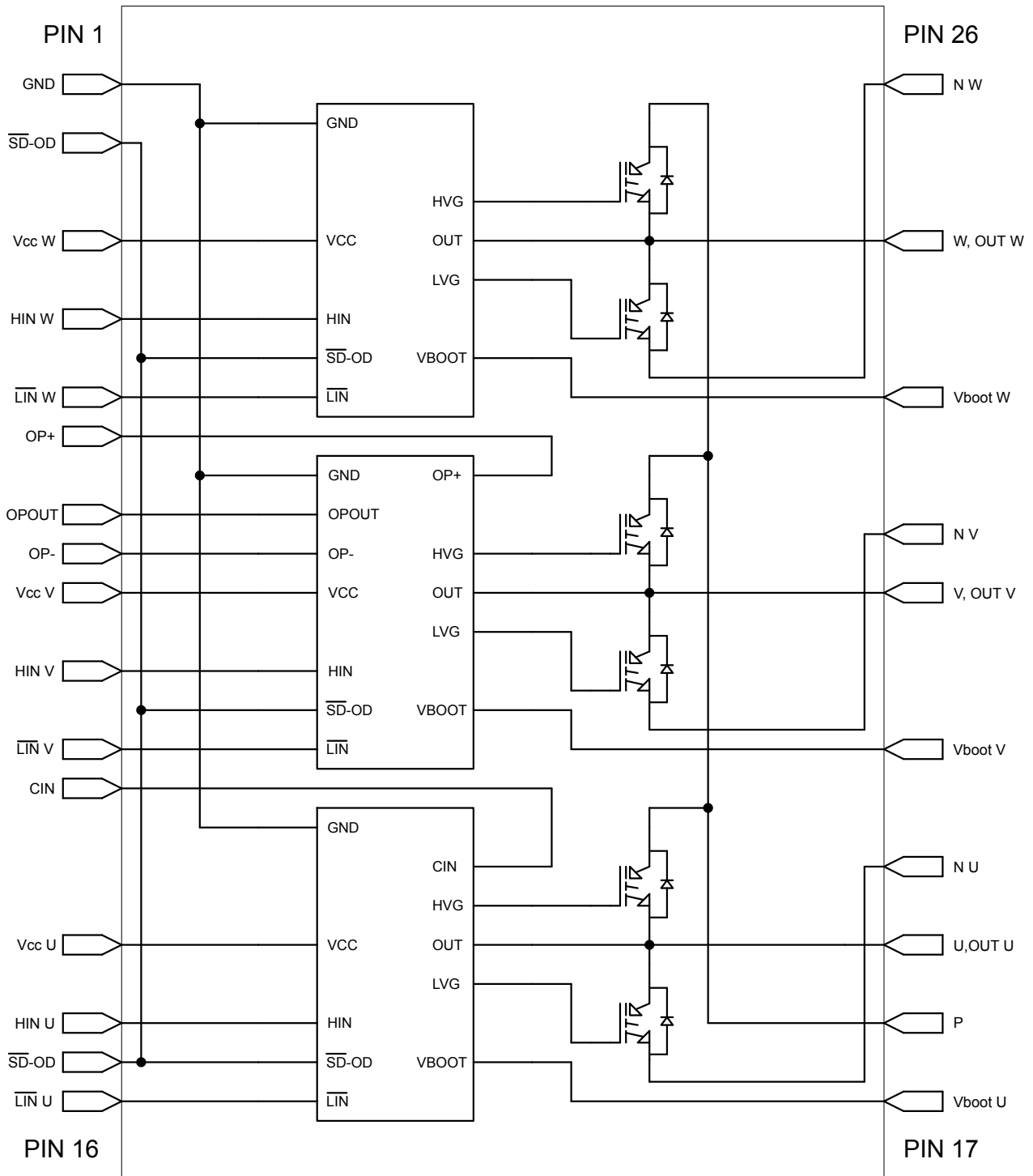
STGIPN3H60

#### Device summary

<b>Order code</b>	STGIPN3H60
<b>Marking</b>	GIPN3H60
<b>Package</b>	NDIP-26L
<b>Packing</b>	Tube

# 1 Internal schematic diagram and pin configuration

Figure 1. Internal schematic diagram

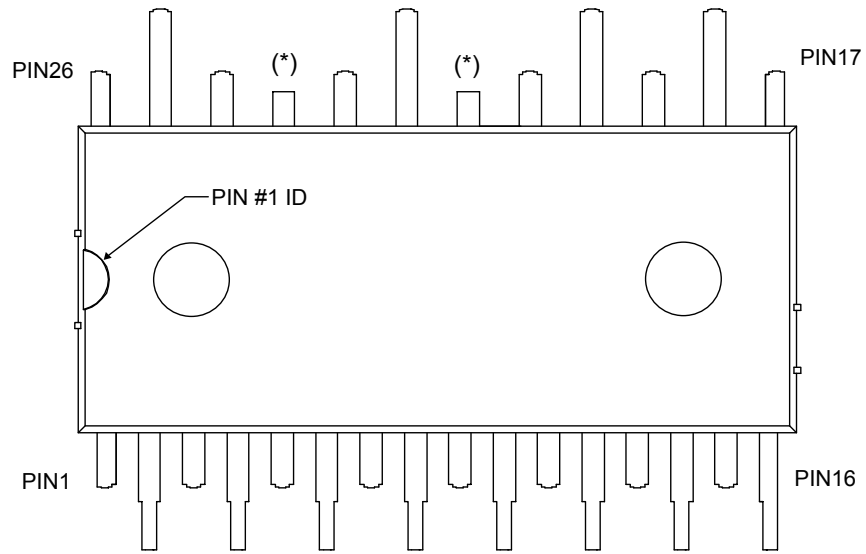


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**Table 1. Pin description**

Pin	Symbol	Description
1	GND	Ground
2	$\overline{SD}$ / OD	Shutdown logic input (active low) / open-drain (comparator output)
3	V <sub>CC W</sub>	Low voltage power supply W phase
4	HIN W	High-side logic input for W phase
5	$\overline{LIN}$ W	Low-side logic input for W phase
6	OP+	Op-amp non inverting input
7	OP <sub>OUT</sub>	Op-amp output
8	OP-	Op-amp inverting input
9	V <sub>CC V</sub>	Low voltage power supply V phase
10	HIN V	High-side logic input for V phase
11	$\overline{LIN}$ V	Low-side logic input for V phase
12	CIN	Comparator input
13	V <sub>CC U</sub>	Low voltage power supply for U phase
14	HIN U	High-side logic input for U phase
15	$\overline{SD}$ / OD	Shutdown logic input (active low) / open-drain (comparator output)
16	$\overline{LIN}$ U	Low-side logic input for U phase
17	V <sub>BOOT U</sub>	Bootstrap voltage for U phase
18	P	Positive DC input
19	U, OUT <sub>U</sub>	U phase output
20	N <sub>U</sub>	Negative DC input for U phase
21	V <sub>BOOT V</sub>	Bootstrap voltage for V phase
22	V, OUT <sub>V</sub>	V phase output
23	N <sub>V</sub>	Negative DC input for V phase
24	V <sub>BOOT W</sub>	Bootstrap voltage for W phase
25	W, OUT <sub>W</sub>	W phase output
26	N <sub>W</sub>	Negative DC input for W phase

**Figure 2. Pin layout (top view)**



(\*) Dummy pin internally connected to P (positive DC input).

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## 2 Electrical ratings

### 2.1 Absolute maximum ratings

**Table 2. Inverter part**

Symbol	Parameter	Value	Unit
$V_{CES}$	Each IGBT collector emitter voltage ( $V_{IN}^{(1)} = 0$ )	600	V
$\pm I_C$	Continuous collector current each IGBT ( $T_C = 25\text{ }^\circ\text{C}$ )	3	A
$\pm I_{CP}^{(2)}$	Pulsed collector current each IGBT (less than 1 ms)	18	A
$P_{TOT}$	Total power dissipation each IGBT ( $T_C = 25\text{ }^\circ\text{C}$ )	9.7	W

1. Applied between  $HIN_i$ ,  $\overline{LIN}_i$  and  $G_{ND}$  for  $i = U, V, W$ .
2. Pulse width limited by max. junction temperature.

**Table 3. Control part**

Symbol	Parameter	Min.	Max.	Unit
$V_{OUT}$	Output voltage applied between $OUT_U, OUT_V,$ $OUT_W - GND$	$V_{boot} - 21$	$V_{boot} + 0.3$	V
$V_{CC}$	Low voltage power supply	- 0.3	21	V
$V_{CIN}$	Comparator input voltage	- 0.3	$V_{CC} + 0.3$	V
$V_{op+}$	Op-amp non-inverting input	- 0.3	$V_{CC} + 0.3$	V
$V_{op-}$	Op-amp inverting input	- 0.3	$V_{CC} + 0.3$	V
$V_{boot}$	Bootstrap voltage	- 0.3	620	V
$V_{IN}$	Logic input voltage applied among $HIN, \overline{LIN}$ and GND	- 0.3	15	V
$V_{SD/OD}$	Open-drain voltage	- 0.3	15	V
$dV_{out}/dt$	Allowed output slew rate		50	V/ns

**Table 4. Total system**

Symbol	Parameter	Value	Unit
$V_{ISO}$	Isolation withstand voltage applied between each pin and heat sink plate (AC voltage, $t = 60\text{ s}$ )	1000	Vrms
$T_J$	Power chip operating junction temperature range	-40 to 150	$^\circ\text{C}$
$T_C$	Module operation case temperature range	-40 to 125	$^\circ\text{C}$

## 2.2 Thermal data

**Table 5. Thermal data**

Symbol	Parameter	Value	Unit
$R_{th(j-c)}$	Thermal resistance junction-case single IGBT	12.8	°C/W
	Thermal resistance junction-case single diode	15.5	
$R_{th(j-a)}$	Thermal resistance junction-ambient (per module)	22	

### 3 Electrical characteristics

#### 3.1 Inverter part

$T_J = 25\text{ °C}$  unless otherwise specified.

**Table 6. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 0\text{ to }5\text{ V}$ , $I_C = 1\text{ A}$	-	2.15	2.6	V
		$V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 0\text{ to }5\text{ V}$ , $I_C = 1\text{ A}$ , $T_J = 125\text{ °C}$	-	1.65		
$I_{CES}$	Collector cut-off current ( $V_{IN}^{(1)} = 0$ "logic state")	$V_{CE} = 550\text{ V}$ , $V_{CC} = 15\text{ V}$ , $V_{BS} = 15\text{ V}$	-		250	$\mu\text{A}$
$V_F$	Diode forward voltage	$V_{IN}^{(1)} = 0$ "logic state", $I_C = 1\text{ A}$	-		1.7	V

1. Applied between  $HIN_i$ ,  $LIN_i$  and GND for  $i = U, V, W$  ( $LIN$  inputs are active low).

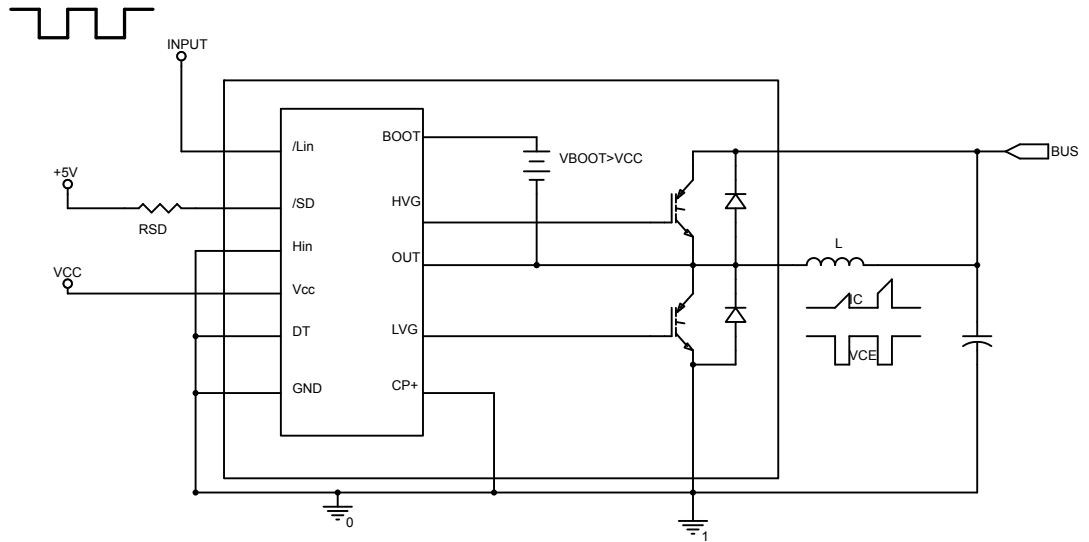
**Table 7. Inductive load switching time and energy**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{on}^{(1)}$	Turn-on time	$V_{DD} = 300\text{ V}$ , $V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(2)} = 0\text{ to }5\text{ V}$ , $I_C = 1\text{ A}$ (see Figure 4. Switching time definition)	-	275	-	ns
$t_{c(on)}^{(1)}$	Crossover time (on)		-	90	-	
$t_{off}^{(1)}$	Turn-off time		-	890	-	
$t_{c(off)}^{(1)}$	Crossover time (off)		-	125	-	
$t_{rr}$	Reverse recovery time		-	50	-	
$E_{on}$	Turn-on switching energy		-	18	-	$\mu\text{J}$
$E_{off}$	Turn-off switching energy	-	13	-		

1.  $t_{ON}$  and  $t_{OFF}$  include the propagation delay time of the internal drive.  $t_{C(ON)}$  and  $t_{C(OFF)}$  are the switching time of IGBT itself under the internally given gate driving conditions.

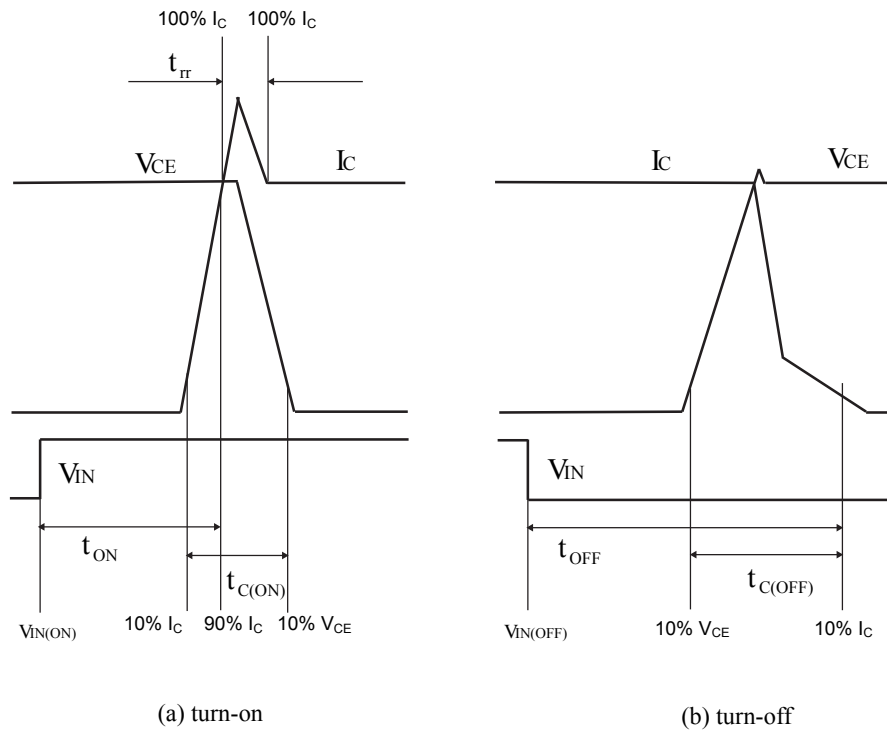
2. Applied between  $HIN_i$ ,  $LIN_i$  and GND for  $i = U, V, W$  ( $LIN$  inputs are active low).

Figure 3. Switching time test circuit



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Figure 4. Switching time definition



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Figure 4. Switching time definition refers to  $\overline{HIN}$  inputs (active high). For  $\overline{LIN}$  inputs (active low),  $V_{IN}$  polarity must be inverted for turn-on and turn-off.



### 3.2 Control part

( $V_{CC} = 15\text{ V}$  unless otherwise specified).

**Table 8. Low voltage power supply**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{CC\_hys}$	$V_{CC}$ UV hysteresis		1.2	1.5	1.8	V
$V_{CC\_thON}$	$V_{CC}$ UV turn-ON threshold		11.5	12	12.5	V
$V_{CC\_thOFF}$	$V_{CC}$ UV turn-OFF threshold		10	10.5	11	V
$I_{qccu}$	Undervoltage quiescent supply current	$V_{CC} = 15\text{ V}$ , $\overline{SD}/OD = 5\text{ V}$ , $\overline{LIN} = 5\text{ V}$ , $HIN = 0\text{ V}$ , $CIN = 0\text{ V}$			150	$\mu\text{A}$
$I_{qcc}$	Quiescent current	$V_{CC} = 15\text{ V}$ , $\overline{SD}/OD = 5\text{ V}$ , $\overline{LIN} = 5\text{ V}$ , $HIN = 0\text{ V}$ , $CIN = 0\text{ V}$			1	mA
$V_{ref}$	Internal comparator (CIN) reference voltage		0.5	0.54	0.58	V

**Table 9. Bootstrapped voltage**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{BS\_hys}$	$V_{BS}$ UV hysteresis		1.2	1.5	1.8	V
$V_{BS\_thON}$	$V_{BS}$ UV turn-ON threshold		11.1	11.5	12.1	V
$V_{BS\_thOFF}$	$V_{BS}$ UV turn-OFF threshold		9.8	10	10.6	V
$I_{QBSU}$	Undervoltage $V_{BS}$ quiescent current	$V_{BS} < 9\text{ V}$ , $\overline{SD}/OD = 5\text{ V}$ , $\overline{LIN}$ and $HIN = 5\text{ V}$ , $CIN = 0\text{ V}$		70	110	$\mu\text{A}$
$I_{QBS}$	$V_{BS}$ quiescent current	$V_{BS} = 15\text{ V}$ , $\overline{SD}/OD = 5\text{ V}$ , $\overline{LIN}$ and $HIN = 5\text{ V}$ , $CIN = 0\text{ V}$		200	300	$\mu\text{A}$
$R_{DS(on)}$	Bootstrap driver on-resistance	LVG ON		120		$\Omega$

**Table 10. Logic inputs**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{il}$	Low logic level voltage		0.8		1.1	V
$V_{ih}$	High logic level voltage		1.9		2.25	V
$I_{HINh}$	HIN logic "1" input bias current	$HIN = 15\text{ V}$	110	175	260	$\mu\text{A}$
$I_{HINl}$	HIN logic "0" input bias current	$HIN = 0\text{ V}$			1	$\mu\text{A}$
$I_{LINl}$	$\overline{LIN}$ logic "1" input bias current	$\overline{LIN} = 0\text{ V}$	3	6	20	$\mu\text{A}$
$I_{LINh}$	$\overline{LIN}$ logic "0" input bias current	$\overline{LIN} = 15\text{ V}$			1	$\mu\text{A}$
$I_{SDh}$	$\overline{SD}$ logic "0" input bias current	$\overline{SD} = 15\text{ V}$	30	120	300	$\mu\text{A}$
$I_{SDl}$	$\overline{SD}$ logic "1" input bias current	$\overline{SD} = 0\text{ V}$			3	$\mu\text{A}$
$Dt$	Dead time	see Figure 5. Dead time and interlocking waveform definitions		180		ns

**Table 11. Op-amp characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{io}$	Input offset voltage	$V_{ic} = 0\text{ V}$ , $V_o = 7.5\text{ V}$			6	mV
$I_{io}$	Input offset current	$V_{ic} = 0\text{ V}$ , $V_o = 7.5\text{ V}$		4	40	nA
$I_{ib}$	Input bias current <sup>(1)</sup>			100	200	nA
$V_{icm}$	Input common mode voltage range		0			V
$V_{OL}$	Low level output voltage	$R_L = 10\text{ k}\Omega$ to $V_{CC}$		75	150	mV
$V_{OH}$	High level output voltage	$R_L = 10\text{ k}\Omega$ to GND	14	14.7		V
$I_o$	Output short-circuit current	Source, $V_{id} = +1\text{ V}$ ; $V_o = 0\text{ V}$	16	30		mA
		Sink, $V_{id} = -1\text{ V}$ ; $V_o = V_{CC}$	50	80		mA
SR	Slew rate	$V_i = 1 - 4\text{ V}$ ; $C_L = 100\text{ pF}$ ; unity gain	2.5	3.8		V/ $\mu$ s
GBWP	Gain bandwidth product	$V_o = 7.5\text{ V}$	8	12		MHz
$A_{vd}$	Large signal voltage gain	$R_L = 2\text{ k}\Omega$	70	85		dB
SVR	Supply voltage rejection ratio	vs. $V_{CC}$	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

1. The direction of the input current is out of the IC.

**Table 12. Sense comparator characteristics**

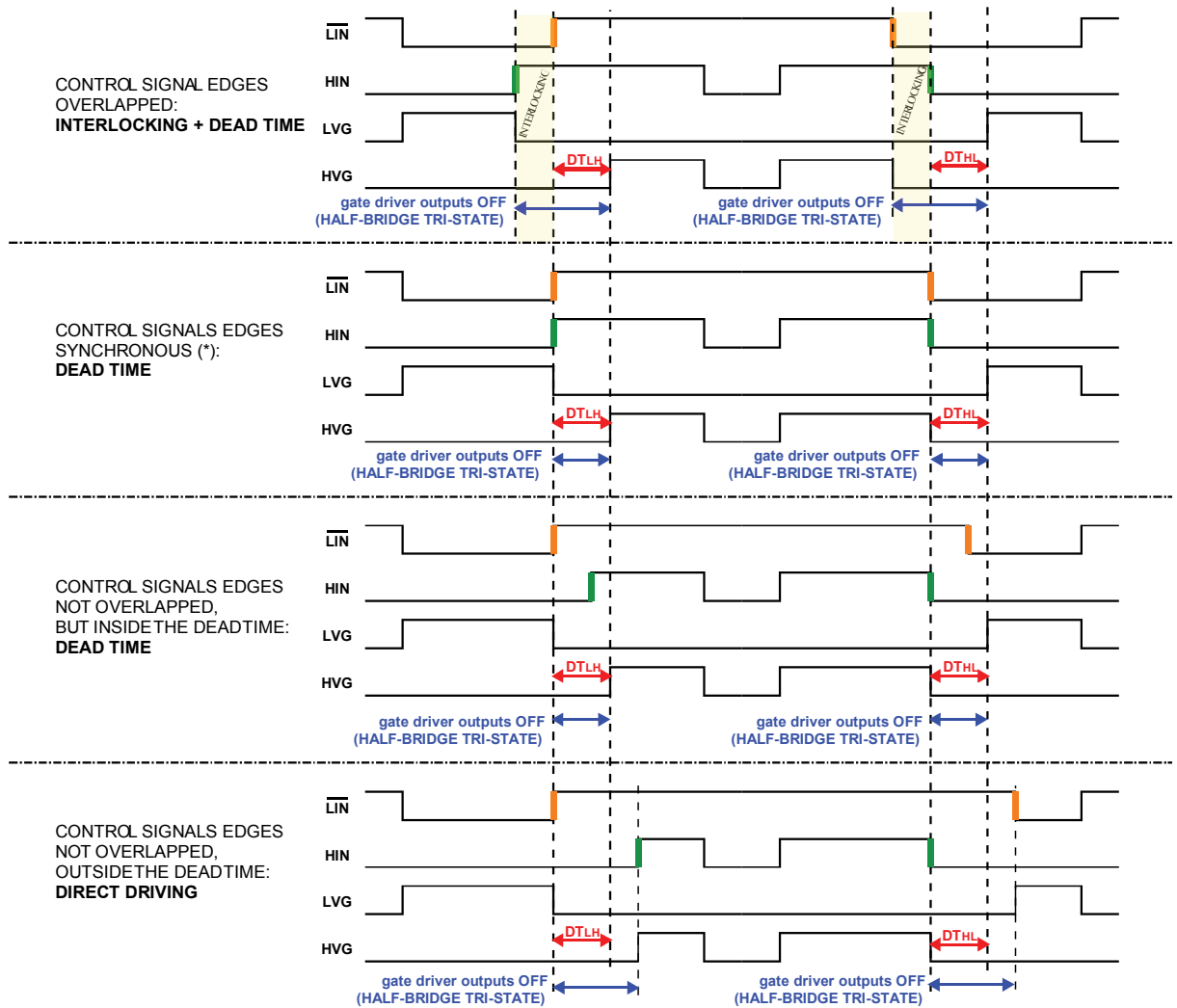
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{ib}$	Input bias current	$V_{CIN} = 1\text{ V}$			1	$\mu$ A
$V_{ol}$	Open-drain low level output voltage	$I_{od} = 3\text{ mA}$			0.5	V
$t_{d\_comp}$	Comparator delay	$\overline{SD}/OD$ pulled to 5 V through 100 k $\Omega$ resistor		90	130	ns
SR	Slew rate	$C_L = 180\text{ pF}$ ; $R_{pu} = 5\text{ k}\Omega$		60		V/ $\mu$ s
$t_{sd}$	Shutdown to high / low-side driver propagation delay	$V_{OUT} = 0$ , $V_{boot} = V_{CC}$ , $V_{IN} = 0$ to 3.3 V	50	125	200	ns
$t_{isd}$	Comparator triggering to high / low-side driver turn-off propagation delay	Measured applying a voltage step from 0 V to 3.3 V to pin CIN	50	200	250	

**Table 13. Truth table**

Condition	Logic input (V <sub>I</sub> )			Output	
	SD /OD	LIN	HIN	LVG	HVG
Shutdown enable half-bridge tri-state	L	X <sup>(1)</sup>	X <sup>(1)</sup>	L	L
Interlocking half-bridge tri-state	H	L	H	L	L
0 "logic state" half-bridge tri-state	H	H	L	L	L
1 "logic state" low-side direct driving	H	L	L	H	L
1 "logic state" high-side direct driving	H	H	H	L	H

1. X: don't care.

### 3.3 Waveform definitions

**Figure 5. Dead time and interlocking waveform definitions**

 (\*) HIN and  $\overline{\text{LIN}}$  can be connected together and driven by just one control signal

## 4 Shutdown function

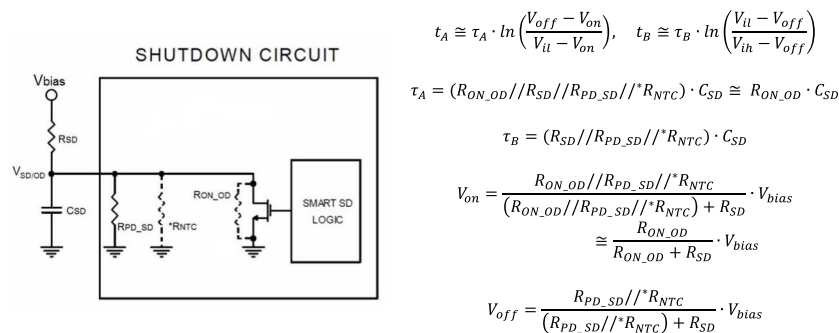
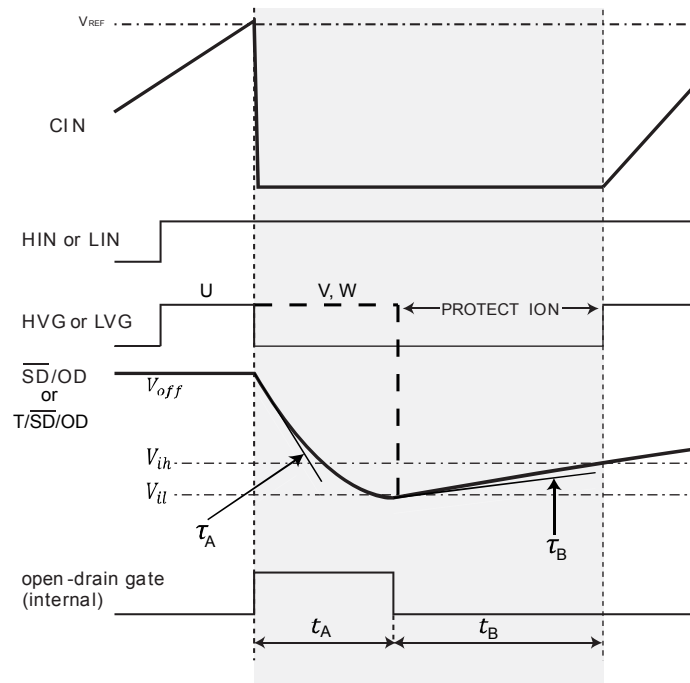
The device is equipped with three half-bridge IC gate drivers and integrates a comparator for fault detection. The comparator has an internal voltage reference  $V_{REF}$  connected to the inverting input, while the non-inverting input pin (CIN) can be connected to an external shunt resistor for current monitoring.

Since the comparator is embedded in the U IC gate driver, in case of fault it disables directly the U outputs, whereas the shutdown of V and W IC gate drivers depends on the RC value of the external SD circuitry, which fixes the disabling time.

For an effective design of the shutdown circuit, please refer to Application note AN4966.

**Figure 6. Shutdown timing waveforms**

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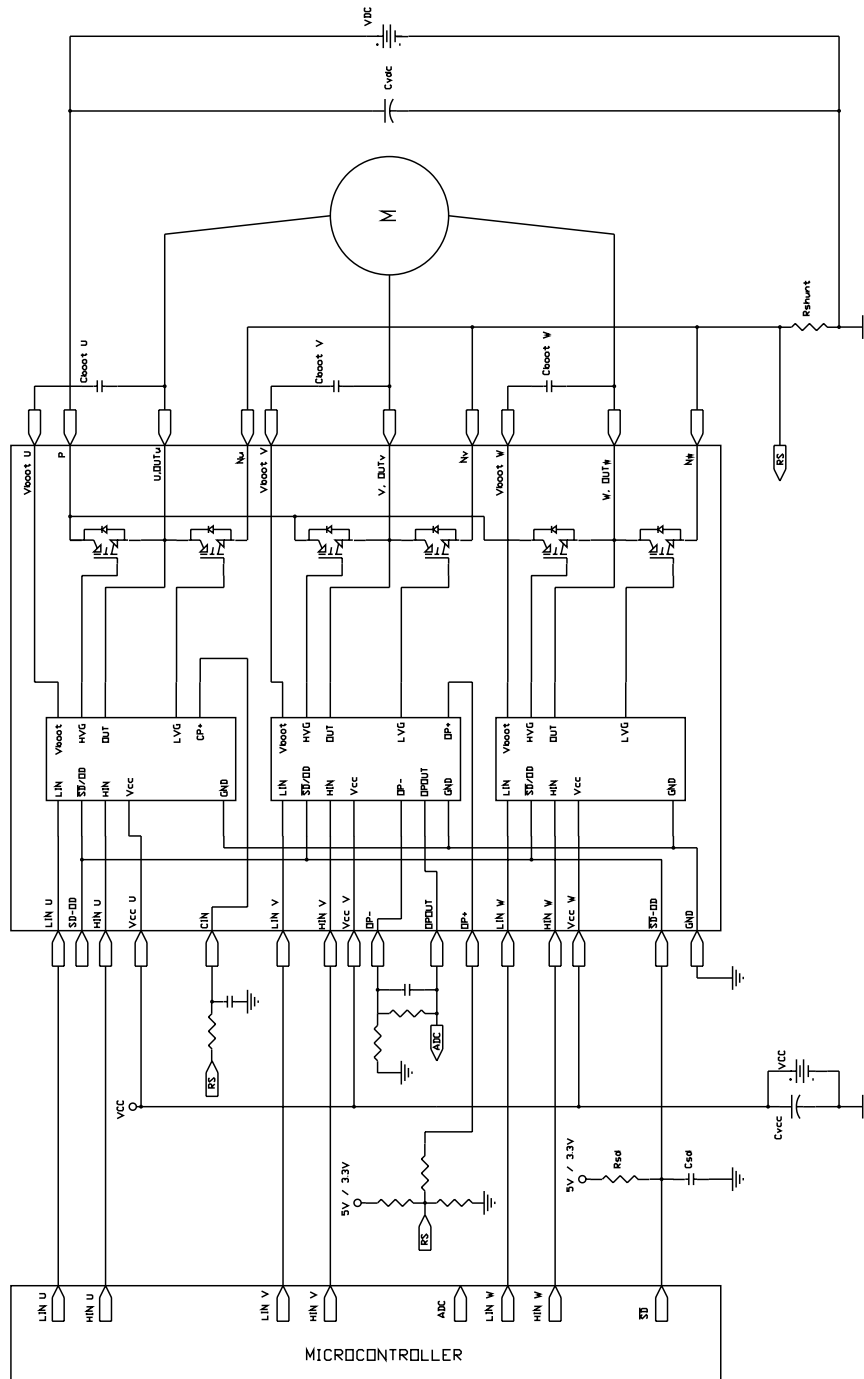
$R_{SD}$  and  $C_{SD}$  external circuitry must be designed to ensure  $V_{on} < V_{il}$  &  $V_{off} > V_{ih}$

Please refer to AN4966 for further details.

\*  $R_{NTC}$  to be considered only when the NTC is internally connected to the T/SD/OD pin.

## 5 Application circuit example

Figure 7. Application circuit example



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Application designers are free to use a different scheme according to the specifications of the device.

## 5.1 Guidelines

- Input signal HIN is active high logic. A pull-down resistor of 85 kΩ (typ.) is built-in for each high-side input. If an external RC filter is used for noise immunity, attention should be given to the variation of the input signal level.
- Input signal  $\overline{\text{LIN}}$  is active low logic. A 720 kΩ (typ.) pull-up resistor, connected to an internal 5 V regulator through a diode, is built-in for each low-side input.
- To avoid input signal oscillation, the wiring of each input should be as short as possible.
- By integrating an application specific type HVIC inside the module, direct coupling to the MCU terminals without an optocoupler is possible.
- Each capacitor should be located as close as possible to pins of IPM.
- Low inductance shunt resistors should be used for phase leg current sensing.
- Electrolytic bus capacitors should be mounted as close to the module bus terminals as possible. Additional high frequency ceramic capacitors mounted close to the module pins improve the performance.
- The  $\overline{\text{SD}}/\text{OD}$  signal should be pulled up to 5 V / 3.3 V with an external resistor (see Smart shutdown function for detailed info).

These guidelines ensure the specifications of the device for application designs. For further details, please refer to the relevant application note AN4043.

**Table 14. Recommended operating conditions**

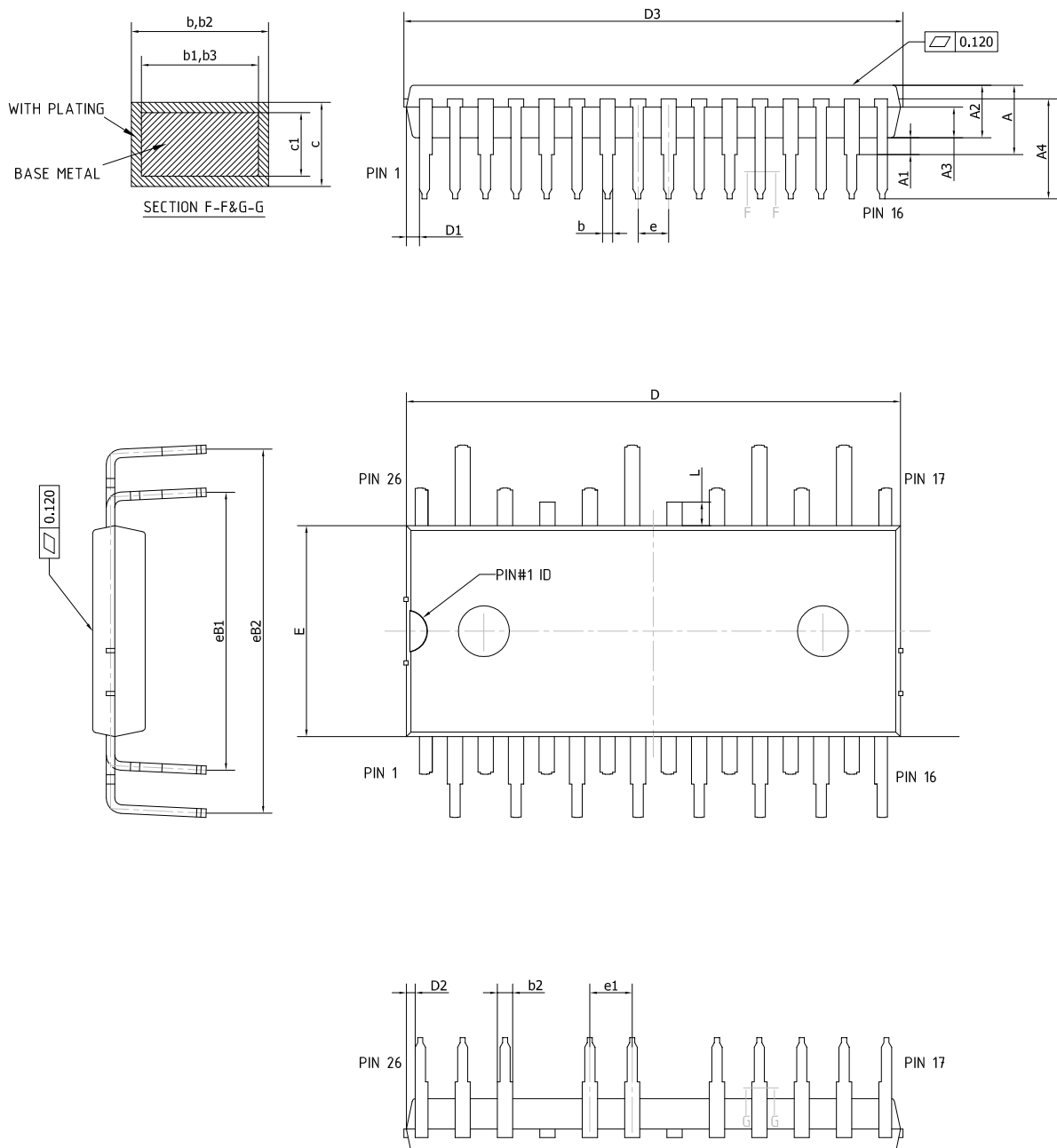
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{PN}$	Supply voltage	Applied between P-Nu, Nv, Nw		300	500	V
$V_{CC}$	Control supply voltage	Applied between $V_{CC}$ -GND	13.5	15	18	V
$V_{BS}$	High-side bias voltage	Applied between $V_{BOOTi}$ - $\text{OUT}_i$ for $i = U, V, W$	13		18	V
$t_{\text{dead}}$	Blanking time to avoid arm-short	For each input signal	1.5			μs
$f_{\text{PWM}}$	PWM input signal	-40 °C < $T_C$ < 100 °C -40 °C < $T_J$ < 125 °C			25	kHz
$T_C$	Case operation temperature				100	°C

## 6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 6.1 NDIP-26L type C package information

**Figure 8. NDIP-26L type C package outline**



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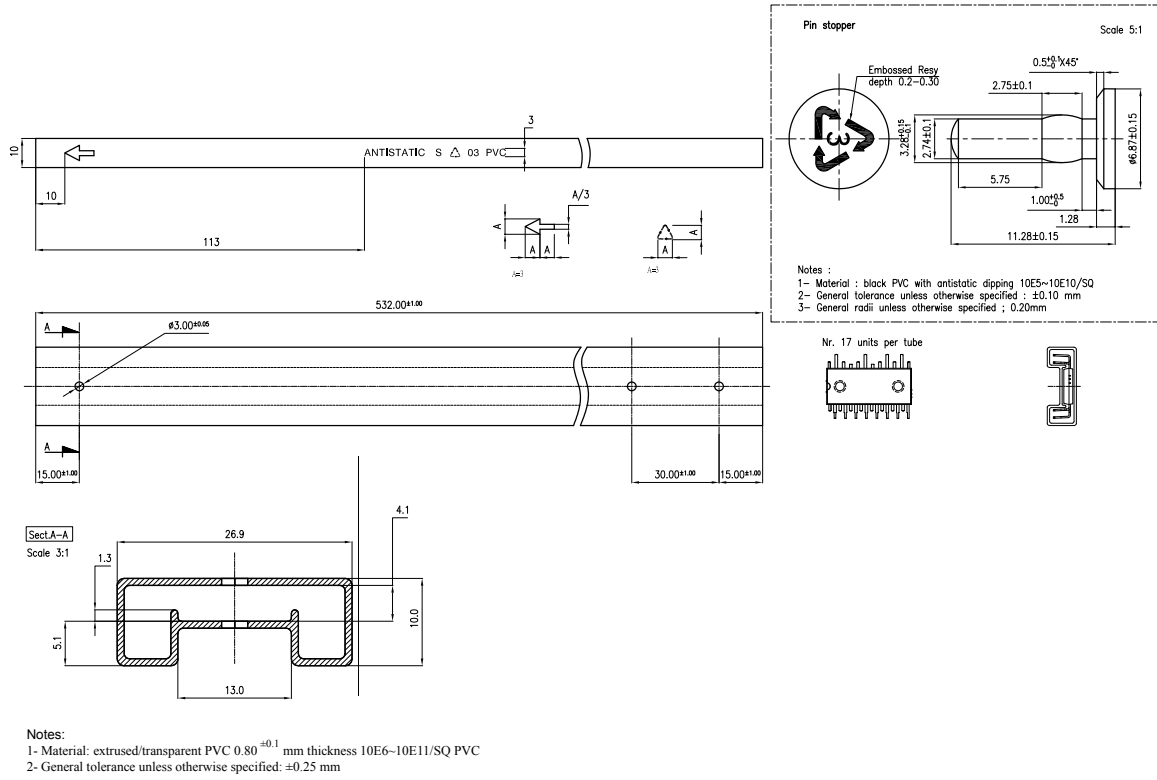
**Table 15. NDIP-26L type C mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A			4.40
A1	0.80	1.00	1.20
A2	3.00	3.10	3.20
A3	1.70	1.80	1.90
A4	5.70	5.90	6.10
b	0.53		0.72
b1	0.52	0.60	0.68
b2	0.83		1.02
b3	0.82	0.90	0.98
c	0.46		0.59
c1	0.45	0.50	0.55
D	29.05	29.15	29.25
D1	0.50	0.77	1.00
D2	0.35	0.53	0.70
D3			29.55
E	12.35	12.45	12.55
e	1.70	1.80	1.90
e1	2.40	2.50	2.60
eB1	16.10	16.40	16.70
eB2	21.18	21.48	21.78
L	1.24	1.39	1.54



## 6.2 NDIP-26L packing information

Figure 9. NDIP-26L tube (dimensions are in mm)



8313150\_3

Table 16. Shipping details

Parameter	Value
Base quantity	17 pieces
Bulk quantity	476 pieces

## Revision history

**Table 17. Document revision history**

Date	Revision	Changes
23-Jun-2011	1	Initial release.
23-Dec-2011	2	Document status promoted from preliminary data to datasheet. Added <i>Figure 9 on page 20</i> .
03-Jul-2012	3	Modified: Min. and Max. value <i>Table 4 on page 6</i> . Added: <i>Table 14 on page 17</i> .
14-Mar-2014	4	Updated <i>Figure 3: Switching time test circuit, Figure 6: Smart shutdown timing waveforms</i> . Updated <i>Table 9: Bootstrapped voltage (VCC = 15 V unless otherwise specified), Table 10: Logic inputs (VCC = 15 V unless otherwise specified)</i> . Updated <i>Section 6: Package mechanical data</i> .
28-Aug-2014	5	Updated unit in <i>Table 9: Bootstrapped voltage (VCC = 15 V unless otherwise specified)</i>
12-Nov-2014	6	Updated unit for Slew rate parameter in <i>Table 11.: OPAMP characteristics (VCC = 15 V unless otherwise specified)</i> Updated <i>6: Package mechanical data</i> .
16-Mar-2017	7	Updated <i>Section 6.1: "NDIP-26L type C package information" and Section 6.2: "NDIP-26L packing information"</i> . Minor text changes.
02-Mar-2020	8	Modified title, applications and description on cover page. Modified <i>Table 2. Inverter part, Table 5. Thermal data, Table 6. , Table 8. Low voltage power supply, Table 12. Sense comparator characteristics, Section 4 Shutdown function</i> . Minor text changes.

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